

LMN6184JZF 60V N-Channel MOSFET

Features

- 60V, 2.8A, $R_{DS(ON)}=92m\Omega@V_{GS}=10V$
- Improved dv/dt capability
- Fast switching
- 100% EAS guaranteed.
- Green Device Available
- SOT-23 package design

Product Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has

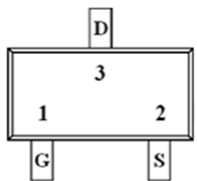
been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

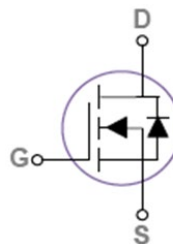
These devices are well suited for high efficiency fast switching applications.

Applications

- Motor Drive
- Power Tools
- LED Lighting

Pin Configuration

LMN6184JZF (SOT-23)	
 <p>Transparent top view</p>	
Pin	Description
1	Gate
2	Drain
3	Source



Ordering Information

Ordering Information					
Part Number	P/N	PKG code	Pb Free code	Package	Quantity
LMN6184JZF	LMN6184	JZ	F	SOT-23	3000 PCS

Marking Information

Marking Information		
Part Marking	Part Number	LFC code
S3XWM	S3	XWM

Absolute Maximum Ratings

(T_C=25°C Unless otherwise noted)

Symbol	Parameter	Typical	Unit
V _{DSS}	Drain-Source Voltage	60	V
V _{GSS}	Gate-Source Voltage	±20	V
I _D	Continuous Drain Current ¹	T _A =25°C	A
		T _A =70°C	
I _{DM}	Pulsed Drain Current	10	A
P _D	Power Dissipation	T _A =25°C	W
		T _A =70°C	
T _J	Operating Junction Temperature	-55 to +150	°C
T _{STG}	Storage Temperature Range	-55 to +150	°C
R _{θJA}	Thermal Resistance-Junction to Ambient ¹	90	°C /W

Electrical Characteristics

(T_C=25°C Unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	60			V
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	1		3	V
I _{GSS}	Gate Leakage Current	V _{DS} =0V, V _{GS} =±20V			±100	nA
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V			1	uA
		V _{DS} =48V, V _{GS} =0V, T _J =125°C			10	
I _S	Continuous Source Current	V _G =V _D =0V, Force Current			6.1	A
I _{SM}	Pulsed Source Current				24.4	
R _{DS(on)}	Drain-Source On-Resistance ²	V _{GS} =10V, I _D =3A		85	92	mΩ
		V _{GS} =4.5V, I _D =2A		90	100	
g _{FS}	Forward Transconductance	V _{DS} =10V, I _D =3A		3.6		S
V _{SD}	Diode Forward Voltage	V _{GS} =0V, I _S =1A			1.2	V
t _{rr}	Reverse Recovery Time	I _S =3A, V _{GS} =0V dI/dt=100A/μs		25		nS
Q _{rr}	Reverse Recovery Charge			26		nC
Dynamic						
Q _g	Total Gate Charge	V _{DS} =48V, V _{GS} =4.5V, I _D =3A		6		nC
Q _{gs}	Gate-Source Charge			1.6		
Q _{gd}	Gate-Drain Charge			3		
C _{iss}	Input Capacitance	V _{DS} =25V, V _{GS} =0V, f=1MHz		490		pF
C _{oss}	Output Capacitance			55		
C _{rss}	Reverse Transfer Capacitance			40		
t _{d(on)}	Turn-On Time ²	V _{DD} =30V, I _D =1A, V _{GS} =4.5V, R _G =6.8Ω		6		ns
t _r				5		
t _{d(off)}	Turn-Off Time ²			16		
t _f				3		

Typical Performance Characteristics

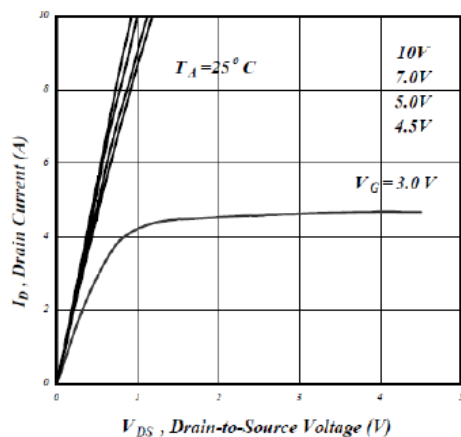


Fig. 1. Typical Output Characteristics

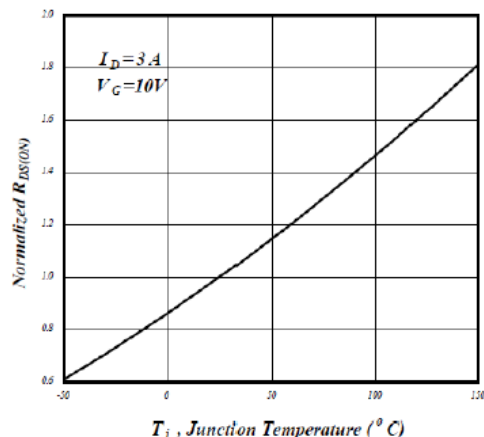
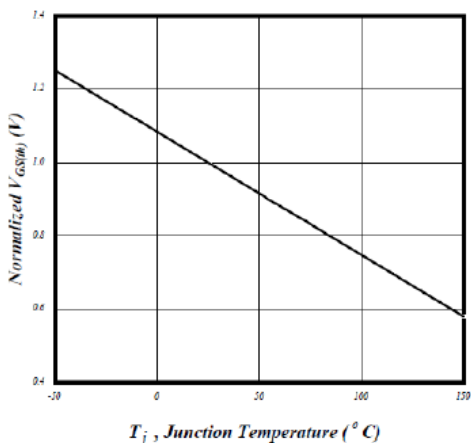
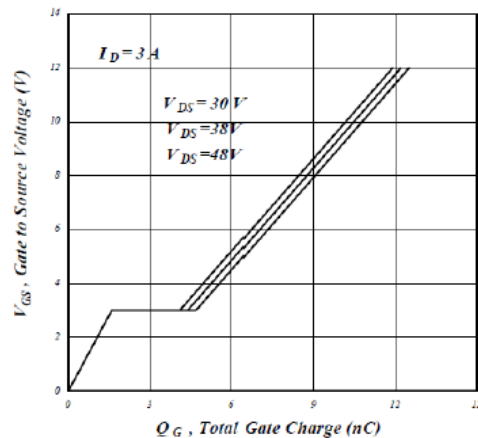

Fig. 2 On-Resistance Variation with T_J

Fig. 3 Gate Threshold Variation vs. T_J


Fig. 4 Gate Charge Waveform

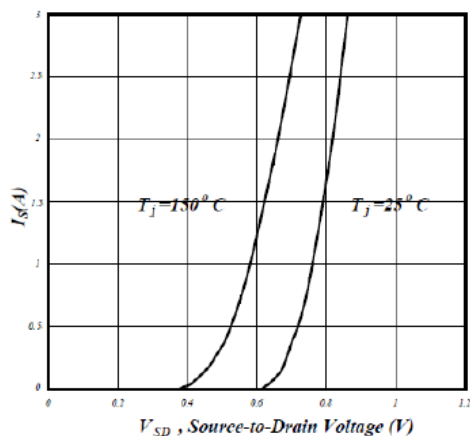


Fig. 5 Diode Forward Voltage vs. Current

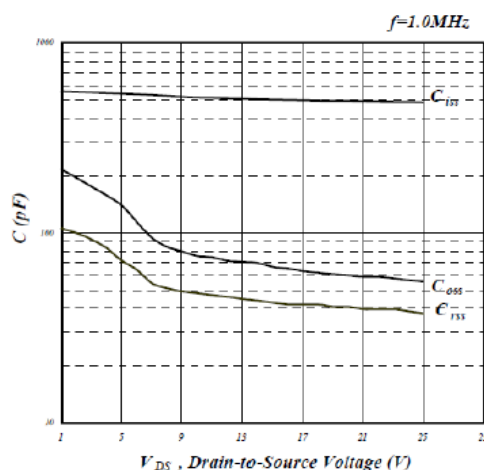


Fig. 6 Typical Capacitance

Typical Performance Characteristics

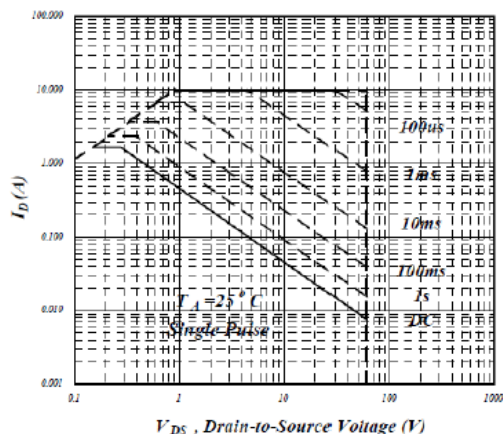


Fig. 7 Maximum Safe Operation Area

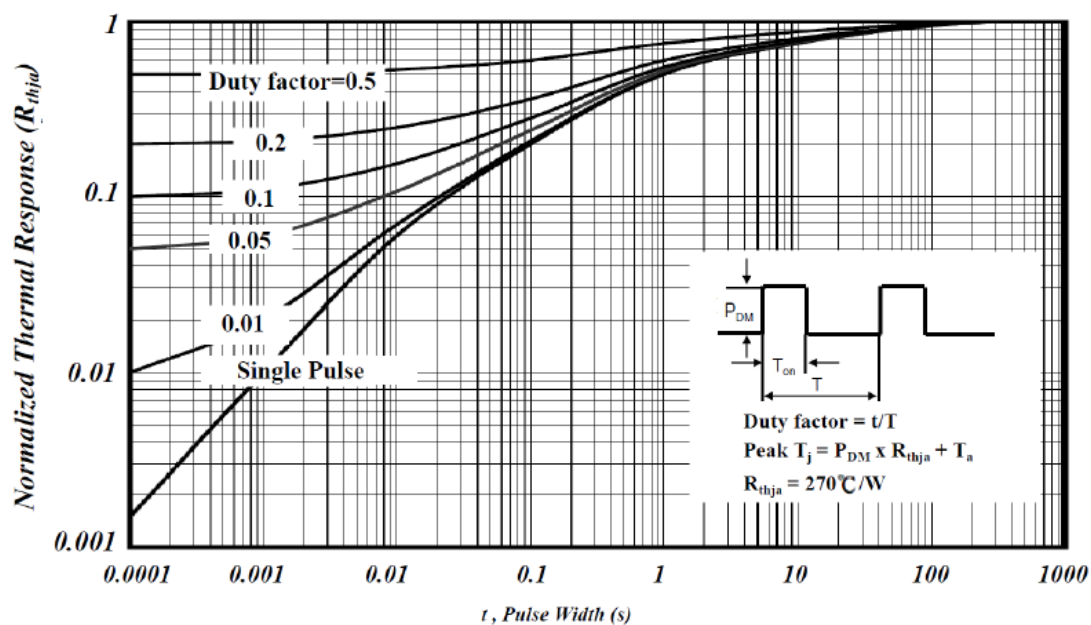
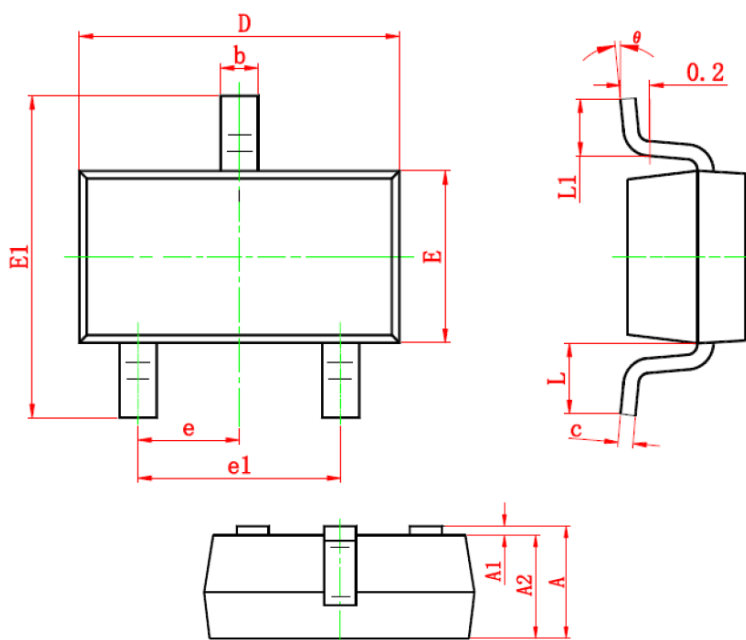


Fig. 11 Transient Thermal Response

Package Dimension:
SOT-23


Dimensions				
Symbol	Millimeters		Inches	
	Min	Max	Min	Max
A	0.90	1.20	0.035	0.043
A1	0.00	0.10	0.000	0.004
A2	0.90	1.10	0.035	0.039
b	0.30	0.50	0.012	0.020
c	0.08	0.15	0.003	0.006
D	2.80	3.00	0.110	0.118
E	1.20	1.40	0.047	0.055
E1	2.25	2.55	0.089	0.100
e	0.95 TYP		0.037 TYP	
e1	1.80	2.00	0.071	0.079
L	0.55 REF		0.022 REF	
L1	0.30	0.50	0.012	0.020
θ	0°	8°	0°	8°

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